


<b>Search Notes</b>  	<b>Application/Control No.</b>  10520262	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  /James A Dudek/	<b>Art Unit</b>  2871

SEARCHED			
Class	Subclass	Date	Examiner
349	60	5/29/08	jad

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	5/29/08	jad

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner